

Applications

- · Military radar
- · Civilian radar
- Professional and military radio communications
- Test instrumentation
- · Wideband or narrowband amplifiers
- Jammers



• Frequency: DC to 6 GHz

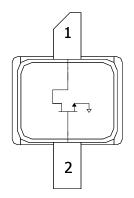
• Output Power (P3dB): 19 W at 5.2 GHz

• Linear Gain: >9 dB at 5.2 GHz • Operating Voltage: 28 V

Low thermal resistance package



Functional Block Diagram



General Description

The TriQuint T2G6001528-Q3 is an 18W (P3dB) discrete GaN on SiC HEMT which operates from DC to 6.0 GHz. The device is constructed with TriQuint's proven TQGaN25 process, which features advanced field plate techniques to optimize power and efficiency at high drain bias operating conditions. This optimization can potentially lower system costs in terms of fewer amplifier line-ups and lower thermal management costs.

Lead-free and ROHS compliant

Evaluation boards are available upon request.

Pin Configuration

Pin No.	Label
1	V _D / RF OUT
2	V _G / RF IN
Flange	Source

Ordering Information

Part	ECCN	Description
T2G6001528-Q3	EAR99	Packaged part Flangeless
T2G6001528-Q3- EVB1	EAR99	5.0 – 6.0 GHz Evaluation Board
T2G6001528-Q3- EVB2	EAR99	1.8 – 2.6 GHz Evaluation Board



Absolute Maximum Ratings

Parameter	Value
Breakdown Voltage (BV _{DG})	100 V min.
Gate Voltage Range (V _G)	-7 to 0 V
Drain Current (ID)	5 A
Gate Current (I _G)	-5 to 14 mA
Power Dissipation (P _D)	28 W
RF Input Power, CW, T = 25 ℃ (P _{IN})	36 dBm
Channel Temperature (T _{CH})	275 ℃
Mounting Temperature (30 seconds)	320 ℃
Storage Temperature	-40 to 150 ℃

Operation of this device outside the parameter ranges given above may cause permanent damage. These are stress ratings only, and functional operation of the device at these conditions is not implied.

Recommended Operating Conditions(1)

Parameter	Value
Drain Voltage (V _D)	32 V (Typ.)
Drain Quiescent Current (I _{DQ})	50 mA (Typ.)
Peak Drain Current (ID)	1.4 A (Typ.)
Gate Voltage (V _G)	-2.9 V (Typ.)
Channel Temperature (T _{CH})	225 ℃ (Max)
Power Dissipation, CW (P _D) ²	20.9 W (Max)
Power Dissipation, Pulse (PD) ³	22.5 W (Max)

¹ Electrical specifications are measured at specified test conditions.

Specifications are not guaranteed over all recommended operating conditions.

RF Characterization - Load Pull Performance at 3.0 GHz

Test conditions unless otherwise noted: T_A = 25 °C, V_D = 28 V, I_{DQ} = 50 mA, Pulse: 100uS, 20%

Symbol	Parameter	Min	Typical	Max	Units
G_{LIN}	Linear Gain		16.5		dB
P _{3dB}	Output Power at 3 dB Gain Compression		19.6		W
DE _{3dB}	Drain Efficiency at 3 dB Gain Compression		69.6		%
PAE _{3dB}	Power-Added Efficiency at 3 dB Gain		66.4		%
G _{3dB}	Gain at 3 dB Compression		13.5		dB

RF Characterization - Load Pull Performance at 6.0 GHz

Test conditions unless otherwise noted: T_A = 25 °C, V_D = 28 V, I_{DQ} = 50 mA, Pulse: 100uS, 20%

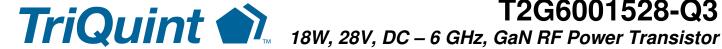
Symbol	Parameter	Min	Typical	Max	Units
GLIN	Linear Gain		11.3		dB
P _{3dB}	Output Power at 3 dB Gain Compression		19.0		W
DE _{3dB}	Drain Efficiency at 3 dB Gain Compression		66.0		%
PAE _{3dB}	Power-Added Efficiency at 3 dB Gain		56.2		%
G _{3dB}	Gain at 3 dB Compression		8.3		dB

Datasheet: Rev C 05-13-15 © 2015 TriQuint

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² Package at 85 ℃

^{3 100}uS Pulse Width, 20 % Duty Cycle, package at 85 ℃



RF Characterization – Performance at 5.2 GHz (1)

Test conditions unless otherwise noted: TA = 25 °C, VD = 28 V, IDQ = 50 mA, Pulse: 100uS, 20%

Symbol	Parameter	Min	Typical	Max	Units
GLIN	Linear Gain		10.5		dB
P _{3dB}	Output Power at 3 dB Gain Compression		17.3		W
DE _{3dB}	Drain Efficiency at 3 dB Gain Compression		48.0		%
G _{3dB}	Gain at 3 dB Compression		7.5		dB

Notes:

RF Characterization – Mismatch Ruggedness at 3.50 GHz (1)

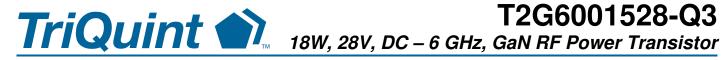
Test conditions unless otherwise noted: $T_A = 25$ °C, $V_D = 28$ V, $I_{DQ} = 50$ mA

Symbol	Parameter	Typical
VSWR	Impedance Mismatch Ruggedness	10:1

Notes:

1. $V_{DS} = 28 \text{ V}$, $I_{DQ} = 50 \text{ mA}$, CW at P_{1dB}

^{1.} Performance at 5.2 GHz in the 5.0 to 6.0 GHz Evaluation Board



Thermal and Reliability Information - Pulsed

Parameter	Test Conditions	Value	Units
Thermal Resistance (θ _{JC})	D. I'	4.6	°C/W
Channel Temperature (T _{CH})	Pdiss = 22.5W, Pulse width = 100 uS, Duty cycle = 5%, Tbase = 85 ℃	188	∞
Median Lifetime (T _M)	Duty cycle = 376, Tbase = 65 G	4.9 E7	Hrs
Thermal Resistance (θ _{JC})	D. II	4.7	°C/W
Channel Temperature (T _{CH})	Pdiss = 22.5W, Pulse width = 100 uS, Duty cycle = 10%, Tbase = 85 ℃	191	∞
Median Lifetime (T _M)	Duty cycle = 10%, Tbase = 85°C	3.6 E7	Hrs
Thermal Resistance (θ _{JC})	D.I	5.0	°C/W
Channel Temperature (T _{CH})	Pdiss = 22.5W, Pulse width = 100 uS, Duty cycle = 20%, Tbase = 85 °C	198	∞
Median Lifetime (T _M)	Duty Cycle = 20 %, 1 base = 05 0	1.9 E7	Hrs
Thermal Resistance (θ _{JC})	D.I	5.6	°C/W
Channel Temperature (T _{CH})	Pdiss = 22.5W, Pulse width = 100 uS, Duty cycle = 50%, Tbase = 85 °C	212	∞
Median Lifetime (T _M)	Duty Cyclo = 30 /0, 10ase = 05 0	5.5 E6	Hrs

Notes:

Thermal resistance measured to bottom of package, Pulsed.

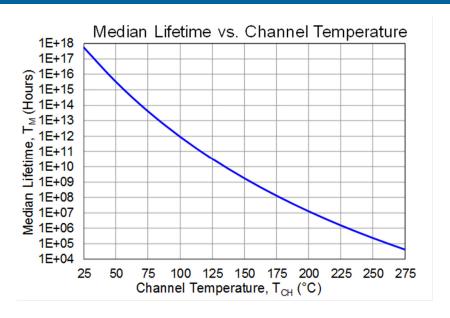
Therma	and R	eliability	Informat	ion – CW

Parameter	Test Conditions	Value	Units
Thermal Resistance (θ _{JC})		6.2	°C/W
Channel Temperature (T _{CH})	Pdiss = 15W, Tbase = 85 ℃	178	℃
Median Lifetime (T _M)		1.3 E8	Hrs
Thermal Resistance (θ _{JC})		6.5	°C/W
Channel Temperature (T _{CH})	Pdiss = 17.5W, Tbase = 85 ℃	198	℃
Median Lifetime (T _M)		1.9 E7	Hrs
Thermal Resistance (θ _{JC})		6.7	°C/W
Channel Temperature (T _{CH})	Pdiss = 20W, Tbase = 85 ℃	219	℃
Median Lifetime (T _M)		3.0 E6	Hrs
Thermal Resistance (θ _{JC})		7.0	°C/W
Channel Temperature (T _{CH})	Pdiss = 22.5W, Tbase = 85 ℃	243	℃
Median Lifetime (T _M)		4.4 E5	Hrs

Notes:

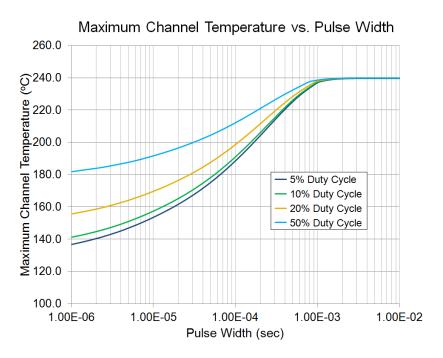
Thermal resistance measured to bottom of package, CW.

Median Lifetime



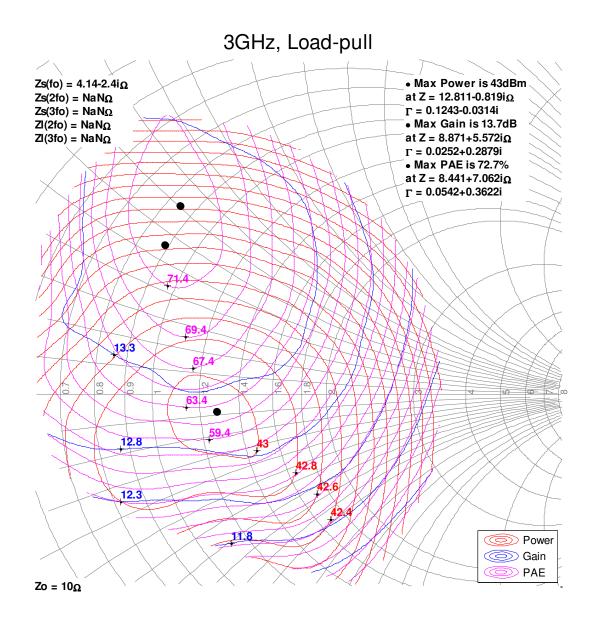
Maximum Channel Temperature

 $T_{BASE} = 85 \,^{\circ}\text{C}, P_D = 22.5 \,^{\circ}\text{W}$



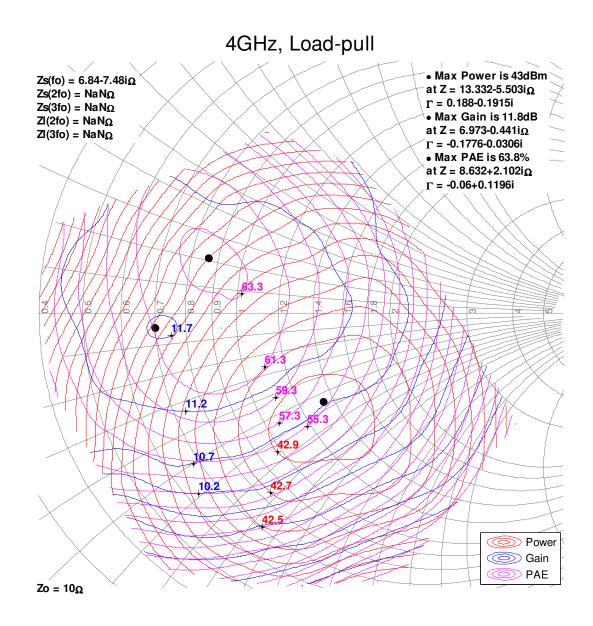


- The impedances shown are those presented to the device at load pull reference planes. See page 14.
- Test Conditions: $V_{DS} = 28 \text{ V}$, $I_{DQ} = 50 \text{ mA}$
- Test Signal: Pulse Width = 100 μsec, Duty Cycle = 20%
- NaN indicates the value was not set during load pull.
- Zo is characteristic impedance of load pull fixtures.



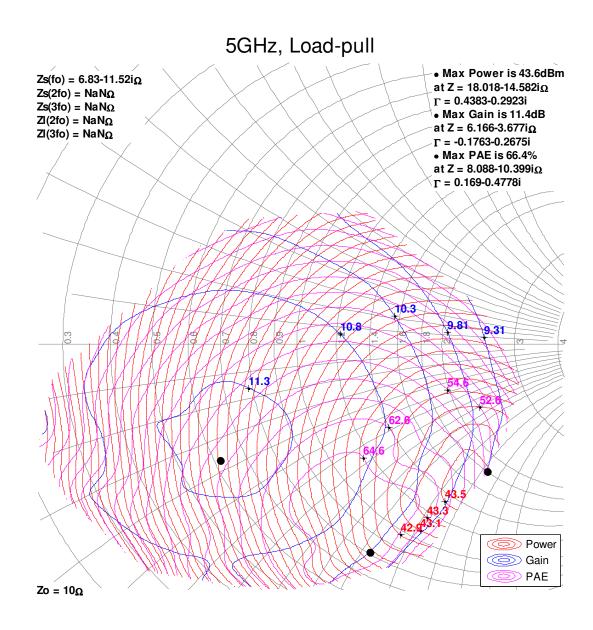


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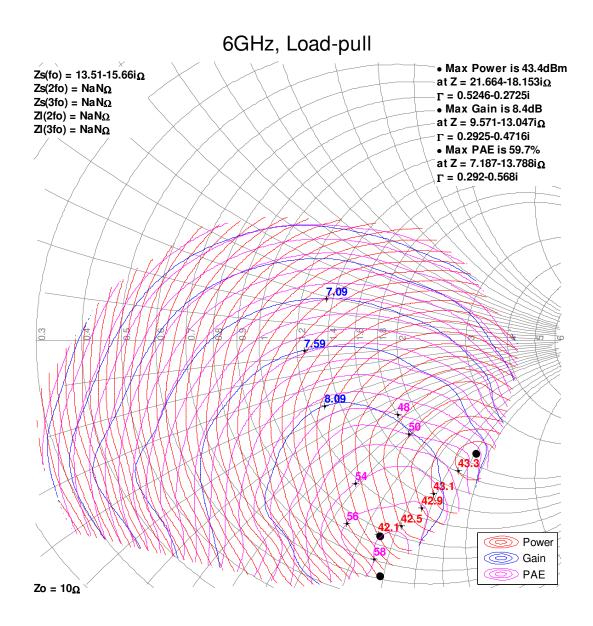


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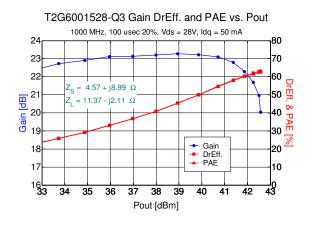


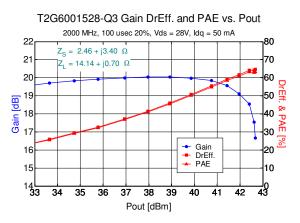
- The impedances shown are those presented to the device at load pull reference planes. See page 14.
- Test Conditions: $V_{DS} = 28 \text{ V}$, $I_{DQ} = 50 \text{ mA}$
- Test Signal: Pulse Width = 100 μsec, Duty Cycle = 20%
- NaN indicates the value was not set during load pull.
- Zo is characteristic impedance of load pull fixtures.

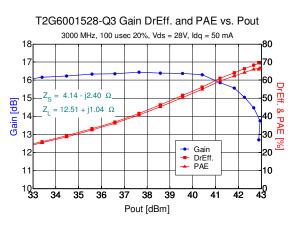


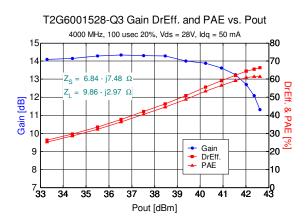
Typical Performance

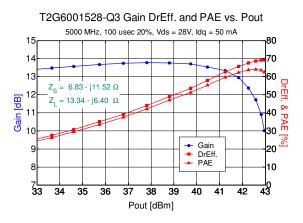
Performance is based on compromised impedance point and measured at DUT reference planes. See page 14.

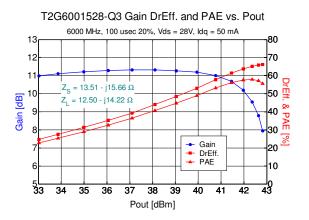






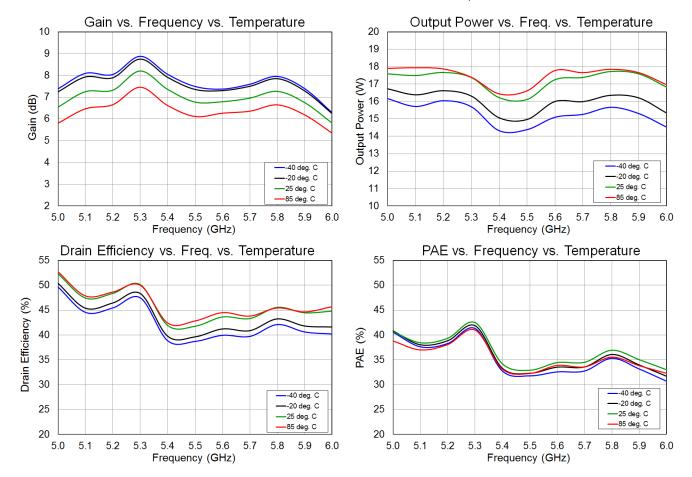






Performance Over Temperature (1, 2)

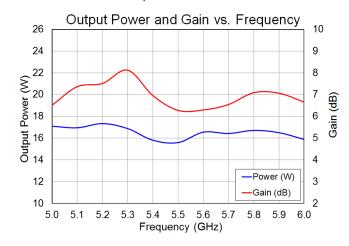
Performance measured in TriQuint's 5.0 GHz to 6.0 GHz Evaluation Board at 3 dB compression.

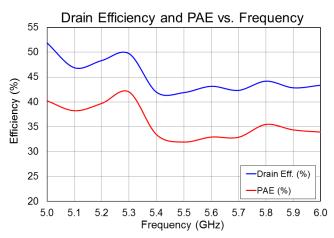


- 1. Test Conditions: V_{DS} = 28 V, I_{DQ} = 50 mA
- 2. Test Signal: Pulse Width = 100 μs, Duty Cycle = 20%

Evaluation Board Performance (1, 2)

Performance at 3 dB Compression

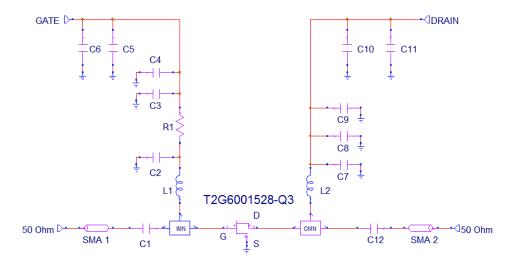




Notes:

- 1. Test Conditions: V_{DS} = 28 V, I_{DQ} = 50 mA
- 2. Test Signal: Pulse Width = 100 μs, Duty Cycle = 20 %

Application Circuit



Bias-up Procedure

Set gate voltage (V_G) to -5.0V

Set drain voltage (VD) to 28 V

Slowly increase V_G until quiescent I_D is 50 mA.

Apply RF signal

Bias-down Procedure

Turn off RF signal

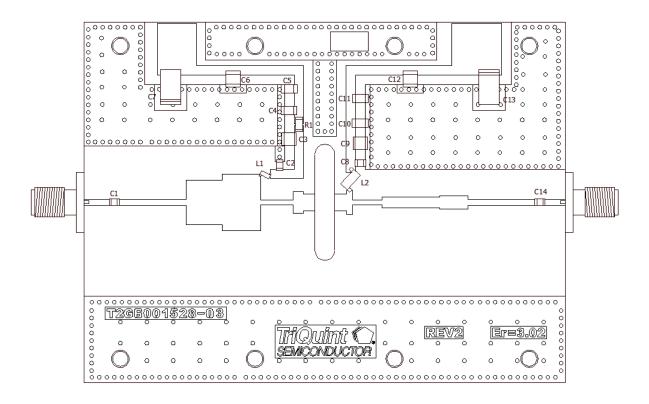
Turn off V_D and wait 1 second to allow drain capacitor dissipation

Turn off V_G



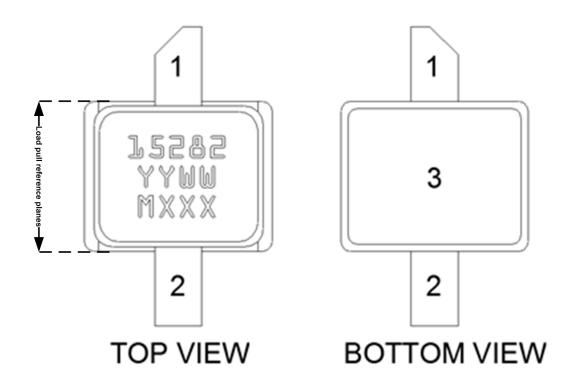
Evaluation Board Layout

Top RF layer is 0.020" thick Rogers RO3203, $\varepsilon_r = 3.02$. The pad pattern shown has been developed and tested for optimized assembly at TriQuint Semiconductor. The PCB land pattern has been developed to accommodate lead and package tolerances.



Bill of Materials Reference Design Value Manufacturer **Part Number** Qty C1, C14 2 ATC 100A101JW500XC 100 pF C2, C8 2400 pF 1 Dielectric Labs C08BL242X-5UN-XOB C3, C9 100 pF 2 **ATC** 100B101GT500X C4, C10 0.01 uF 2 Kemet C1206C103K1RACTU C5, C11 2 0.1 uF Kemet C1206C104K1RACTU AVX 2 C6, C12 1.0 uF 1812C105KAT2A C7, C13 22 uF 2 Sprague 226K035AT Coilcraft L1 5.4 nH 1 0906-5JL L2 9.85 nH 1 Coilcraft 1606-9JLB R₁ 12.10hms Vishay CRC120612R1FKEA

Pin Layout



Note:

The T2G6001528-Q3 will be marked with the "15282" designator and a lot code marked below the part designator. The "YY" represents the last two digits of the calendar year the part was manufactured, the "WW" is the work week of the assembly lot start, and the "MXXX" is the production lot number.

Pin Description

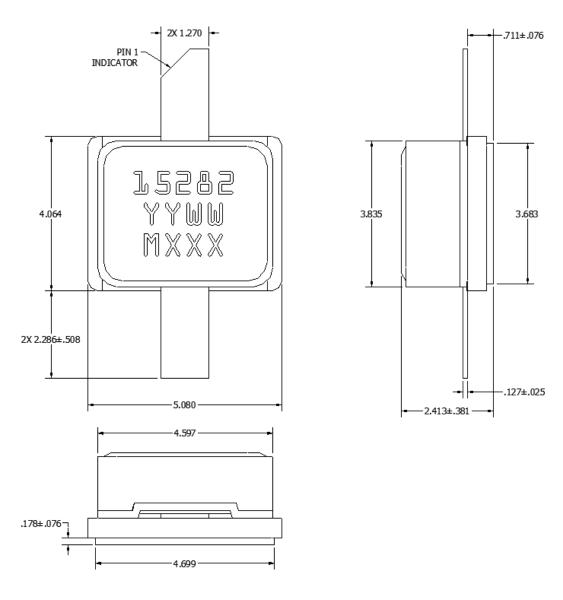
Pin	Symbol	Description
1	V _D / RF OUT	Drain voltage / RF Output matched to 50 ohms; see EVB Layout on page 9 as an example.
2	V _G / RF IN	Gate voltage / RF Input matched to 50 ohms; see EVB Layout on page 9 as an example.
3	Flange	Source connected to ground; see EVB Layout on page 9 as an example.

Notes:

Thermal resistance measured to bottom of package

Mechanical Information

All dimensions are in millimeters. Unless specified otherwise, tolerances are \pm 0.127.

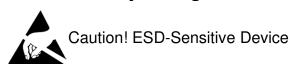


Note:

This package is lead-free/RoHS-compliant. The plating material on the leads is NiAu. It is compatible with both lead-free (maximum 260 °C reflow temperature) and tin-lead (maximum 245 °C reflow temperature) soldering processes.

Product Compliance Information

ESD Sensitivity Ratings



ESD Rating: Class 1A

Value: Passes ≥ 250 V to < 500 V max. Test: Human Body Model (HBM) JEDEC Standard JESD22-A114 Standard:

MSL Rating

Level 3 at +260 °C convection reflow The part is rated Moisture Sensitivity Level 3 at 260 ℃ per JEDEC standard IPC/JEDEC J-STD-020.

Solderability

Compatible with the latest version of J-STD-020, Lead free solder, 260° C

RoHs Compliance

This part is compliant with EU 2002/95/EC RoHS directive (Restrictions on the Use of Certain Hazardous Substances in Electrical and Electronic Equipment).

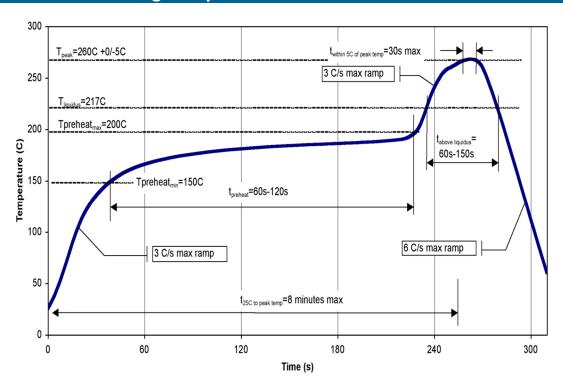
This product also has the following attributes:

- Lead Free
- Halogen Free (Chlorine, Bromine)
- Antimony Free
- TBBP-A (C₁₅H₁₂Br₄O₂) Free
- **PFOS Free**
- **SVHC Free**

ECCN

US Department of Commerce EAR99

Recommended Soldering Temperature Profile





T2G6001528-Q3

Contact Information

For the latest specifications, additional product information, worldwide sales and distribution locations, and information about TriQuint:

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For technical questions and application information: Email: info-products@triquint.com

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